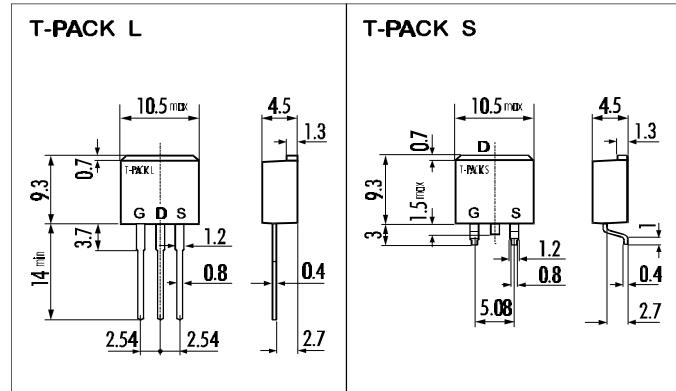


**> Features**

- High Current
- Low On-Resistance
- No Secondary Breakdown
- Low Driving Power
- High Forward Transconductance

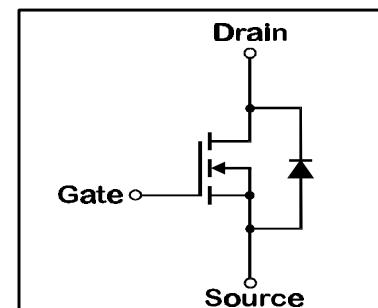
**> Applications**

- Motor Control
- General Purpose Power Amplifier
- DC-DC converters

**> Outline Drawing**

**> Maximum Ratings and Characteristics**

- Absolute Maximum Ratings ( $T_C=25^\circ\text{C}$ ), unless otherwise specified

Item	Symbol	Rating	Unit
Drain-Source-Voltage	$V_{DS}$	150	V
Drain-Gate-Voltage ( $R_{GS}=20\text{ k}\Omega$ )	$V_{DGR}$	150	V
Continous Drain Current	$I_D$	20	A
Pulsed Drain Current	$I_{D(\text{puls})}$	80	A
Gate-Source-Voltage	$V_{GS}$	$\pm 20$	V
Max. Power Dissipation	$P_D$	80	W
Operating and Storage Temperature Range	$T_{ch}$	150	$^\circ\text{C}$
	$T_{stg}$	-55 ~ +150	$^\circ\text{C}$

**> Equivalent Circuit**


- Electrical Characteristics ( $T_C=25^\circ\text{C}$ ), unless otherwise specified

Item	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Drain-Source Breakdown-Voltage	$V_{(BR)DSS}$	$I_D=1\text{ mA}$ $V_{GS}=0\text{ V}$	150			V
Gate Threshold Voltage	$V_{GS(\text{th})}$	$I_D=1\text{ mA}$ $V_{DS}=V_{GS}$	1,0	1,5	2,5	V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS}=150\text{ V}$ $T_{ch}=25^\circ\text{C}$		10	500	$\mu\text{A}$
		$V_{GS}=0\text{ V}$ $T_{ch}=125^\circ\text{C}$		0,2	1,0	mA
Gate Source Leakage Current	$I_{GSS}$	$V_{GS}=\pm 20\text{ V}$ $V_{DS}=0\text{ V}$		10	100	nA
Drain Source On-State Resistance	$R_{DS(on)}$	$I_D=10\text{ A}$ $V_{GS}=4\text{ V}$		0,065	0,1	$\Omega$
		$I_D=10\text{ A}$ $V_{GS}=10\text{ V}$		0,055	0,08	$\Omega$
Forward Transconductance	$g_{fs}$	$I_D=10\text{ A}$ $V_{DS}=25\text{ V}$	10	20		S
Input Capacitance	$C_{iss}$	$V_{DS}=25\text{ V}$		2300	3450	pF
				330	500	pF
		$V_{GS}=0\text{ V}$ $f=1\text{ MHz}$		150	230	pF
Turn-On-Time $t_{on}$ ( $t_{on}=t_{d(on)}+t_r$ )	$t_{d(on)}$	$V_{CC}=30\text{ V}$		15	25	ns
				20	30	ns
Turn-Off-Time $t_{off}$ ( $t_{off}=t_{d(off)}+t_f$ )	$t_{d(off)}$	$V_{GS}=10\text{ V}$		450	700	ns
				100	150	ns
Avalanche Capability	$I_{AV}$	$L=100\mu\text{H}$ $T_{ch}=25^\circ\text{C}$	20			A
Diode Forward On-Voltage	$V_{SD}$	$I_F=2 \times I_{DR}$ $V_{GS}=0\text{ V}$ $T_{ch}=25^\circ\text{C}$		1,1	1,5	V
Reverse Recovery Time	$t_{rr}$	$I_F=I_{DR}$ $V_{GS}=0\text{ V}$		125		ns
Reverse Recovery Charge	$Q_{rr}$			0,6		$\mu\text{C}$

**- Thermal Characteristics**

Item	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Thermal Resistance	$R_{th(ch-a)}$	channel to air			125	$^\circ\text{C/W}$
	$R_{th(ch-c)}$	channel to case			1,56	$^\circ\text{C/W}$

N-channel MOS-FET

150V 0,08Ω 20A 80W

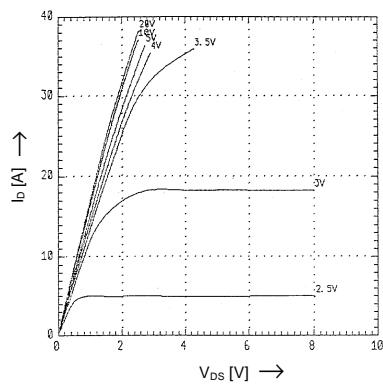
# 2SK2226-01L,S

## F-III Series

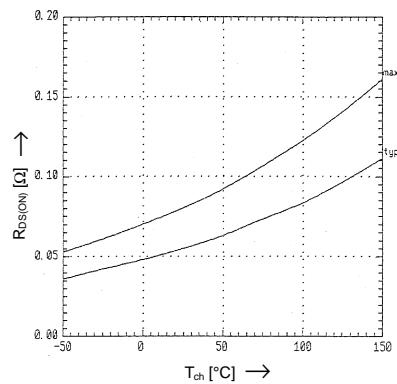
**FUJI**  
**ELECTRIC**

### > Characteristics

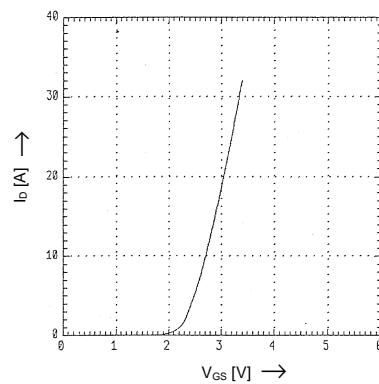
Typical Output Characteristics



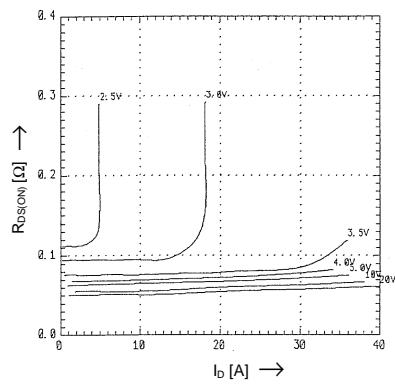
Drain-Source-On-State Resistance vs.  $T_{ch}$



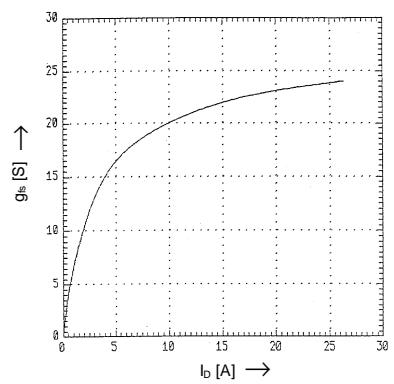
Typical Transfer Characteristics



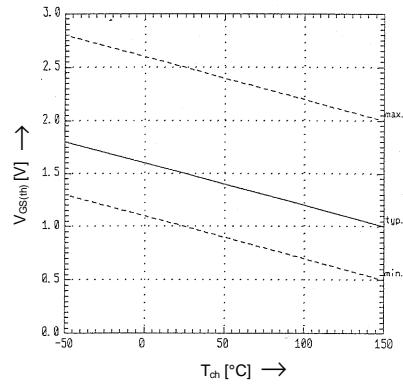
Typical Drain-Source-On-State-Resistance vs.  $I_D$



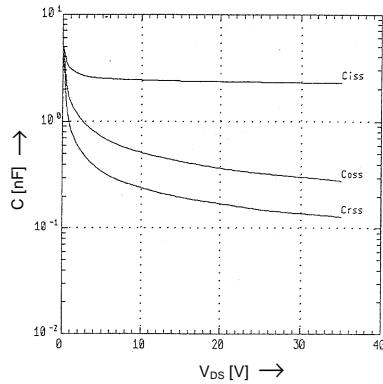
Typical Forward Transconductance vs.  $I_D$



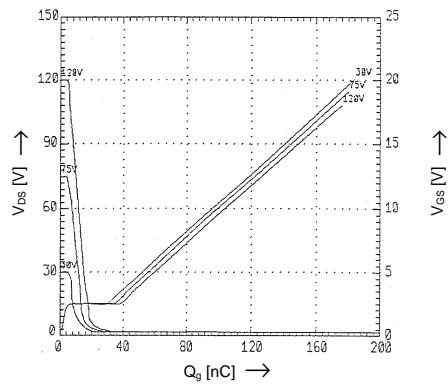
Gate Threshold Voltage vs.  $T_{ch}$



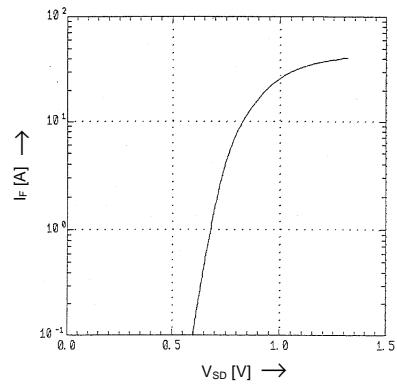
Typical Capacitance vs.  $V_{DS}$



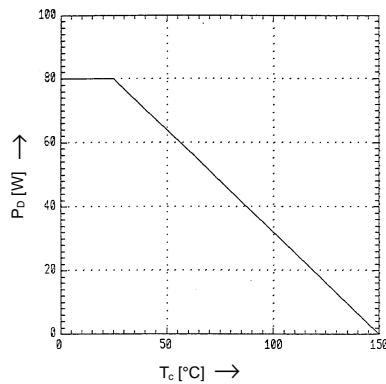
Typical Input Charge



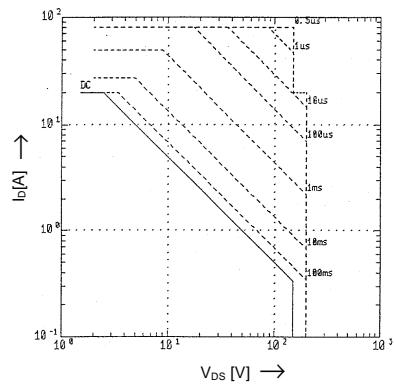
Forward Characteristics of Reverse Diode



Allowable Power Dissipation vs.  $T_c$



Safe operation area



Transient Thermal Impedance

